Application/Control No. Applicant(s)/Patent Under Reexamination 10/617,285 YAKURA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2861 Shih-wen Hsieh **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 347/29 US-6,637,856 10-2003 Nishi et al. Α В US-С US-D US-US-Ε US-F US-G US-Н US-1 J US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Country Code-Number-Kind Code Date Name Classification Country MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

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